

#### Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

	TEST REPORT FCC Part 27
Report Reference No FCC ID	
Compiled by ( position+printed name+signature) :	File administrators Xudong Zhang
Supervised by ( position+printed name+signature) :	Project Engineer Zoey Cao
Approved by ( position+printed name+signature) :	RF Manager Eric Wang
Date of issue	Dec. 18, 2024
Testing Laboratory Name	Shenzhen CTA Testing Technology Co., Ltd.
Address	Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China
Applicant's name	SHENZHEN WAYFOR WARD ELECTRONIC CO.,LTD
Address	2nd floor, A13 building, qinghu guigudingli park, daheroad, longhua district, shenzhen, 518000 China
Test specification	-ING
	FCC CFR Title 47 Part 2, Part 27
Standard	ANSI/TIA-603-E-2016 KDB 971168 D01
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Shenzhen CTA Testing Technology C Shenzhen CTA Testing Technology C	<ul> <li>n whole or in part for non-commercial purposes as long as the co., Ltd. is acknowledged as copyright owner and source of the material co., Ltd. takes no responsibility for and will not assume liability for interpretation of the reproduced material due to its placement and</li> <li>smart watch</li> <li>N/A</li> <li>SHENZHEN WAYFOR WARD ELECTRONIC CO.,LTD</li> <li>LEM10</li> <li>LEM18, LEM19, LEM20, LEM21, LEM22, LEM23</li> </ul>
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# **TEST REPORT**

GIN CTATESTIC	port No.: CTA241210002	09	Page 2 d
Equipment under Test       :       smart watch         Model /Type       :       LEM10         Listed Models       :       LEM18, LEM19, LEM20, LEM21, LEM22, LEM23         Model difference       :       The PCB board, circuit, structure and internal of these models are the same, Only model number is different for these model.         Applicant       :       SHENZHEN WAYFOR WARD ELECTRONIC CO.,LTD         Address       :       2nd floor, A13 building, qinghu guigudingli park, daheroad, longhua district, shenzhen, 518000 China         Manufacturer       :       SHENZHEN WAYFOR WARD ELECTRONIC CO.,LTD         Address       :       2nd floor, A13 building, qinghu guigudingli park, daheroad, longhua district, shenzhen, 518000 China         Manufacturer       :       2nd floor, A13 building, qinghu guigudingli park, daheroad, longhua district, shenzhen, 518000 China         In the configuration tested, the EUT complied with the standards specified page 4.       The test report merely corresponds to the test sample.         It is not permitted to copy extracts of these test result without the written permission of the test labor       Graduated floor of the set test result without the written permission of the test labor		TEST PEDOP	CTATES
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#### Report No.: CTA24121000209



	NO.: CTA24121000209	Page 3 of 24
	Contents	GA CTATES.
1 SU	MMARY	(eng
1.1	TEST STANDARDS	
1.2	TEST DESCRIPTION	
1.3	ADDRESS OF THE TEST LABORATORY	
1.4	TEST FACILITY	
1.5	STATEMENT OF THE MEASUREMENT UNCERTAINTY	
2 GE		
		-11-0
2.1	Environmental conditions	
2.2	GENERAL DESCRIPTION OF EUT	
2.3	DESCRIPTION OF TEST MODES AND TEST FREQUENCY	
2.4	Equipments Used during the Test	
2.5	Related Submittal(s) / Grant (s)	
2.6	MODIFICATIONS	
3 TES	ST CONDITIONS AND RESULTS	
3.1	Output Power	G
3.2	PEAK-TO-AVERAGE RATIO (PAR)	1
3.3	Occupied Bandwidth and Emission Bandwidth	
3.4	BAND EDGE COMPLIANCE	
3.5	Spurious Emission	
3.6	FREQUENCY STABILITY UNDER TEMPERATURE & VOLTAGE VARIATIONS	2
4 TES	ST SETUP PHOTOS OF THE EUT	2
5 EX	FERNAL AND INTERNAL PHOTOS OF THE EUT	
	TEST	
	CTA'	

#### 1 SUMMARY

#### **1.1 TEST STANDARDS**

The tests were performed according to following standards:

FCC Part 2: FREQUENCY ALLOCA-TIONS AND RADIO TREATY MAT-TERS; GENERAL RULES AND REG-ULATIONS

FCC Part 27 : MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

ANSI/TIA-603-E-2016: Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.

CTATES ANSI C63.26-2015: IEEE/ANSI Standard for Compliance Testing of Transmitters Used in Licensed Radio Services

FCCKDB971168D01 Power Meas License Digital Systems

#### 1.2 Test Description

FCC Rule No.	Requirements	Verdict
§2.1046, §27.50(h)	ERP ≤ 2W;	PASS
§2.1046, §27.50	Limit≤13dB	PASS
§2.1047	Digitalmodulation	N/A
§2.1049	OBW: Nolimit. EBW: Nolimit.	PASS
§2.1051, §27.53(m)	≤ -13dBm/1%*EBW,in1 MHz bands immediately outside and adjacent to The frequency block.	PASS
§2.1051, §27.53(m)	≤ -13dBm/1MHz, from 9kHz to10th harmonics but outside authorized Operating frequency ranges.	PASS
§2.1055, §27.54	Within authorized bands of operation/frequency block.	PASS
§2.1053, §27.53(m)	≤ -25dBm/1MHz.	PASS
	No.           §2.1046,           §27.50(h)           §2.1046,           §27.50           §2.1047           §2.1047           §2.1051,           §27.53(m)           §2.1055,           §27.54           §2.1053,	No.Requirements $\S2.1046$ , $\$27.50(h)$ ERP $\leq 2W$ ; $\$2.1046$ , $\$27.50$ Limit $\leq 13dB$ $\$2.1047$ Digitalmodulation $\$2.1047$ Digitalmodulation $\$2.1049$ OBW: Nolimit. $\$2.1049$ EBW: Nolimit. $\$2.1051$ , $\$27.53(m)$ $\leq -13dBm/1\%^*EBW,in1$ MHz bands immediately outside and adjacent to The frequency block. $\$2.1051$ , $\$27.53(m)$ $\leq -13dBm/1MHz$ , from 9kHz to10th harmonics but outside authorized Operating frequency ranges. $\$2.1055$ , $\$27.54$ Within authorized bands of operation/frequency block. $\$2.1053$ , $\$2.1053$ , $\leq -25dBm/1MHz$

#### 1.3 Address of the test laboratory

#### Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.4:2014 and CISPR 16-1-4:2010 SVSWR requirement for radiated emission above 1GHz.

### 1.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

#### FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

#### Industry Canada Registration Number. Is: 27890 CAB identifier: CN0127

The Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing.

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

#### 1.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement characteristics; Part 2 " and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. :

Test	Range	Measuremen t Uncertainty	Notes
Radiated Emission	9KHz~30MHz	3.02 dB	(1)
Radiated Emission	30~1000MHz	4.06 dB	(1)
Radiated Emission	1~18GHz	5.14 dB	G (1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)
Output Peak power	30MHz~18GHz	0.55 dB	(1)
Power spectral density	/	0.57 dB	(1)
Spectrum bandwidth	G	1.1%	(1)
Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	3 (1)
Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)
Radiated spurious emission (18GHz-40GHz)	18-40GHz 🕑	5.54 dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



#### **GENERAL INFORMATION** 2

#### 2.1 Environmental conditions

Date of receipt of test sample	:	Dec. 10, 2024
TES		
Testing commenced on	:	Dec. 10, 2024
5		TED
Testing concluded on		Dec. 18, 2024
-	10	

During the measurement the environmental co	onditions were within the listed ranges:		
Normal Temperature:	25°C	0	
Relative Humidity:	55 %	(11)	
Air Pressure:	101 kPa	and the second sec	

# 2.2 General Description of EUT

Product Name:	smart watch
Model/Type reference:	LEM10
Power supply:	DC 3.80V From battery and DC 5.0V From external circuit
Hardware version:	V1.0
Software version:	V1.0
Testing sample ID :	CTA241210002-1# (Engineer sample)
TING	CTA241210002-2# (Normal sample)
LTE	
Operation Band:	E-UTRA Band 41
Support Bandwidth:	Band 41: 5MHz,10MHz,15MHz,20MHz,
TX/RXFrequency Range:	E-UTRA Band 41(2496 MHz -2690MHz)
Modulation Type:	QPSK, 16QAM
Category:	Cat 4
Antenna Type:	Internal antenna
Antenna Gain:	1.00 dBi

Note: For more details, refer to the user's manual of the EUT.

### 2.3 Description of Test Modes and Test Frequency

The EUT has been tested under typical operating condition. The CMW500 used to control the EUT staying in continuous transmitting and receiving mode for testing. Regards to the frequency band operation: the lowest, middle and highest frequency of channel were selected to perform the test, then shown on this report. CTATES'

## 2.4 Equipments Used during the Test

Test Equipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
LISN	R&S	ENV216	CTA-308	2024/08/03	2025/08/02
LISN	R&S	ENV216	CTA-314	2024/08/03	2025/08/02
EMI Test Receiver	R&S	ESPI	CTA-307	2024/08/03	2025/08/02
EMI Test Receiver	R&S	ESCI	CTA-306	2024/08/03	2025/08/02
Spectrum Analyzer	Agilent	> N9020A	CTA-301	2024/08/03	2025/08/02
Spectrum Analyzer	R&S	FSU	CTA-337	2024/08/03	2025/08/02
Vector Signal generator	Agilent	N5182A	CTA-305	2024/08/03	2025/08/02
Analog Signal Generator	R&S	SML03	CTA-304	2024/08/03	2025/08/02
WIDEBAND RADIO COMMUNICATIO N TESTER	CCMW500	R&S	CTA-302	2024/08/03	2025/08/02
Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2024/08/03	2025/08/02
Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2026/10/16
Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2026/10/12
Loop Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2026/10/16
Horn Antenna	Beijing Hangwei Dayang	OBH100400	CTA-336	2023/10/17	2026/10/16
Amplifier	Schwarzbeck	BBV 9745	CTA-312	2024/08/03	2025/08/02
Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2024/08/03	2025/08/02
Directional coupler	NARDA	4226-10	CTA-303	2024/08/03	2025/08/02
High-Pass Filter	XingBo	XBLBQ-GTA18	CTA-402	2024/08/03	2025/08/02
High-Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2024/08/03	2025/08/02
Automated filter bank	Tonscend	JS0806-F	CTA-404	2024/08/03	2025/08/02
Power Sensor	Agilent	U2021XA	CTA-405	2024/08/03	2025/08/02
Amplifier	Schwarzbeck	BBV9719	CTA-406	2024/08/03	2025/08/02
TESTING			GACIN		GA CTA

	21000209	GA		Fa	Ige 8 of 24
Test Equipment	Manufacturer	Model No.	Version number	Calibration Date	Calibration Due Date
EMI Test Software	Tonscend	TS®JS32-RE	5.0.0.2	N/A	N/A
EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A
RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A
RF Test Software	Tonscend	TS®JS1120	3.1.46	ES N/A	N/A

#### 2.5 Related Submittal(s) / Grant (s)

# 2.6 Modifications

CTA TESTING No modifications were implemented to meet testing criteria.

# 3 TEST CONDITIONS AND RESULTS

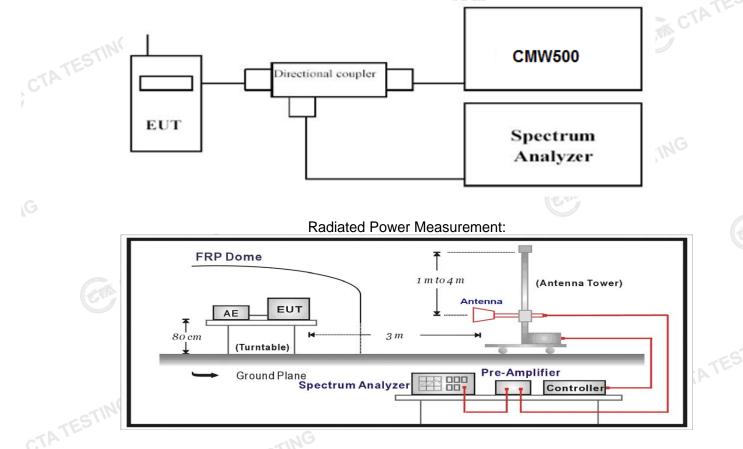
#### 3.1 Output Power

#### <u>LIMIT</u>

The EIRP of mobile transmitters must not exceed 2 Watts for Band 41.

## TEST CONFIGURATION

Conducted Power Measurement



#### TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

#### **Conducted Power Measurement:**

- a) Place the EUT on a bench and set it in transmitting mode.
- b) Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
- c) EUT Communicate with CMW500 then selects a channel for testing.
- d) Add a correction factor to the display of spectrum, and then test.

#### **Radiated Power Measurement:**

- a) The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- b) The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c) The output of the test antenna shall be connected to the measuring receiver.
- d) The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e) The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.

- The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum f) signal level is detected by the measuring receiver.
- The test antenna shall be raised and lowered again through the specified range of height until a g) maximum signal level is detected by the measuring receiver.
- h) The maximum signal level detected by the measuring receiver shall be noted.
- i) The transmitter shall be replaced by a substitution antenna.
- The substitution antenna shall be orientated for vertical polarization and the length of the j) substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k) The substitution antenna shall be connected to a calibrated signal generator.
- If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to I) increase the sensitivity of the measuring receiver.
- m) The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received that the maximum signal is received.
- The input signal to the substitution antenna shall be adjusted to the level that produces a level n) detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- The measurement shall be repeated with the test antenna and the substitution antenna 0) orientated for horizontal polarization.
- The measure of the effective radiated power is the larger of the two levels recorded at the input p) to the substitution antenna, corrected for gain of the substitution antenna if necessary. GTA CTA
- Test site anechoic chamber refer to ANSI C63.4. q)

#### **TEST RESULTS**

EST

# **Conducted Measurement:**

BW (MHz)				LTE Band 41				
(MHz)	Modulation	RB Size	RB Offset		Char	nnel/Frequenc	y(MHz)	
	Woodlation	IND SIZE	IND Oliset	39750 2506	40185 2549.5	40620 2593	41055 2636.5	4149 268
20	QPSK	1	0	23.39	23.35	23.33	23.15	23.2
20	QPSK	1	49	23.44	23.16	22.81	22.90	23.2
20	QPSK	1	99	23.53	23.53	23.61	23.20	22.9
20	QPSK	50	0	21.92	22.11	22.41	22.04	22.2
20	QPSK	50	24	22.04	22.06	22.25	22.17	21.8
20	QPSK	50	50	22.20	21.89	21.92	21.84	22.0
20	QPSK	100	0	22.23	22.12	21.89	21.83	22.0
20	16QAM	1	0	22.31	22.12	22.35	22.01	22.3
20	16QAM	1	49	22.15	21.97	22.15	22.13	22.2
20	16QAM	1	99	21.91	21.92	21.99	21.99	22.0
20	16QAM	50	0	21.31	21.27	21.10	21.22	21.1
20	16QAM	50	24	21.12	21.16	21.37	21.14	21.1
20	16QAM	50	50	21.13	21.05	20.96	21.15	21.2
20	16QAM	100	0	21.05	21.16	21.46	21.23	21.4
BW (MHz)	Modulation	RB Size	RB Offset	39725 2503.5	Char 40173 2548.5	nnel/Frequency 40620 2593	y(MHz) 41068 2637.8	4151 2682
15	QPSK	1	0	23.58	23.40	23.42	23.16	23.1
15	QPSK	1	37	23.12	23.05	23.23	22.99	22.9
15	QPSK	1	74	23.06	23.10	23.37	23.26	23.4
15	QPSK	36	0	21.81	22.13	22.06	22.10	22.0
15	QPSK	36	20	21.98	21.90	21.82	21.93	22.0
15	QPSK	36	39	21.79	21.73	21.96	21.99	21.9
15	QPSK	75	0	22.33	22.12	21.78	22.00	22.0
	16QAM	1	0	22.17	21.87	21.89	21.81	22.0
15	16QAM	1	37	22.12	21.92	21.98	22.13	22.2
15 15	IOGAIVI		74	22.05	21.82	21.95	21.79	22.0
15		1	1 /4					
15 15	16QAM			21.09	21.07	21.34	21.16	<u> </u>
15 15 15	16QAM 16QAM	36	0	21.09 21.12	21.07 21.04	21.34	21.16 21.10	21.1
15 15	16QAM			21.09 21.12 21.24	21.07 21.04 20.96	21.34 21.20 21.21	21.16 21.10 21.08	21.1 21.2 21.0

#### Report No.: CTA24121000209

(cm)~

	Modulation	RB Size	RB Offset		Chanr	nel/Frequency	(MHz)	
(MHz)	Wouldton	IND SIZE	IND Oliset	39700	40160	40620	41080	41540
				2501	2547	2593	2639	2685
10	QPSK	1	0	23.42	23.36	23.14	22.89	23.16
10	QPSK	1	25	23.53	23.40	23.29	23.54	23.60
10	QPSK	1	49	22.84	23.01	23.24	23.64	23.50
10	QPSK	25	0	21.94	21.99	22.21	22.03	21.74
10	QPSK	25	12	22.09	22.19	22.11	22.07	22.28
10	QPSK	25	25	22.00	22.05	22.16	22.22	22.36
10	QPSK	50	0	21.92	22.02	22.05	21.89	22.34
10	16QAM	1	0	22.14	22.31	22.43	22.01	21.97
10	16QAM	1	25	21.93	22.14	22.30	22.06	22.24
10	16QAM	1	49	22.18	22.05	22.01	21.76	22.04
10	16QAM	25	0	21.28	21.08	21.27	21.12	20.97
10	16QAM	25	12	21.26	21.23	21.17	20.97	20.94
10	16QAM	25	25	20.93	21.03	21.20	21.20	21.19
10	16QAM	50	0	21.45	21.28	21.31	21.23	21.02
BW (MHz)	Modulation	RB Size	RB Offset	39675		nel/Frequency 40620	. ,	51565
	Modulation	RB Size	RB Offset	39675 2498.5	40148	40620	41093	
(MHz)		RB Size		2498.5	40148 2545.8	40620 2593	41093 2640.3	2687.5
(MHz) 5	QPSK		0	2498.5 23.17	40148 2545.8 23.64	40620 2593 23.56	41093 2640.3 23.69	2687.5 23.66
(MHz) 5 5	QPSK QPSK	1 1 1	0 12	2498.5 23.17 23.63	40148 2545.8 23.64 23.52	40620 2593 23.56 23.51	41093 2640.3 23.69 23.15	2687.5 23.66 22.82
(MHz) 5 5 5 5	QPSK QPSK QPSK	1 1 1 1	0 12 24	2498.5 23.17 23.63 23.66	40148 2545.8 23.64 23.52 23.57	40620 2593 23.56 23.51 23.64	41093 2640.3 23.69 23.15 23.66	2687.5 23.66 22.82 23.35
(MHz) 5 5	QPSK QPSK	1 1 1	0 12	2498.5 23.17 23.63 23.66 21.90	40148 2545.8 23.64 23.52	40620 2593 23.56 23.51	41093 2640.3 23.69 23.15	22.82
(MHz) 5 5 5 5 5 5 5	QPSK QPSK QPSK QPSK QPSK	1 1 1 12 12	0 12 24 0 7	2498.5 23.17 23.63 23.66 21.90 22.08	40148 2545.8 23.64 23.52 23.57 21.74 21.77	40620 2593 23.56 23.51 23.64 21.81 22.01	41093 2640.3 23.69 23.15 23.66 21.91 22.08	2687.5 23.66 22.82 23.35 22.04 22.25
(MHz) 5 5 5 5 5	QPSK QPSK QPSK QPSK	1 1 1 12	0 12 24 0	2498.5 23.17 23.63 23.66 21.90	40148 2545.8 23.64 23.52 23.57 21.74	40620 2593 23.56 23.51 23.64 21.81	41093 2640.3 23.69 23.15 23.66 21.91	2687.5 23.66 22.82 23.35 22.04
(MHz) 5 5 5 5 5 5 5 5 5	QPSK QPSK QPSK QPSK QPSK QPSK	1 1 12 12 12 12	0 12 24 0 7 13	2498.5 23.17 23.63 23.66 21.90 22.08 22.00	40148 2545.8 23.64 23.52 23.57 21.74 21.77 22.04	40620 2593 23.56 23.51 23.64 21.81 22.01 22.24	41093 2640.3 23.69 23.15 23.66 21.91 22.08 22.13	2687.5 23.66 22.82 23.35 22.04 22.25 22.17
(MHz) 5 5 5 5 5 5 5 5 5 5 5 5	QPSK QPSK QPSK QPSK QPSK QPSK QPSK	1 1 12 12 12 12 25	0 12 24 0 7 13 0	2498.5 23.17 23.63 23.66 21.90 22.08 22.00 22.06	40148 2545.8 23.64 23.52 23.57 21.74 21.77 22.04 21.76	40620 2593 23.56 23.51 23.64 21.81 22.01 22.24 21.78	41093 2640.3 23.69 23.15 23.66 21.91 22.08 22.13 22.18	2687.5 23.66 22.82 23.35 22.04 22.25 22.17 22.17
(MHz) 5 5 5 5 5 5 5 5 5 5 5 5 5 5	QPSK QPSK QPSK QPSK QPSK QPSK QPSK 16QAM	1 1 12 12 12 25 1 1 1 1	0 12 24 0 7 13 0 0	2498.5 23.17 23.63 23.66 21.90 22.08 22.00 22.06 22.33	40148 2545.8 23.64 23.52 23.57 21.74 21.77 22.04 21.76 22.07	40620 2593 23.56 23.51 23.64 21.81 22.01 22.24 21.78 21.86	41093 2640.3 23.69 23.15 23.66 21.91 22.08 22.13 22.13 22.18 22.11	2687.5 23.66 22.82 23.35 22.04 22.25 22.17 22.17 22.17 22.09
(MHz) 5 5 5 5 5 5 5 5 5 5 5 5 5 5	QPSK QPSK QPSK QPSK QPSK QPSK QPSK 16QAM 16QAM	1 1 12 12 12 25 1 1 1	0 12 24 0 7 13 0 0 0 12	2498.5 23.17 23.63 23.66 21.90 22.08 22.00 22.06 22.33 22.01	40148 2545.8 23.64 23.52 23.57 21.74 21.77 22.04 21.76 22.07 21.91	40620 2593 23.56 23.51 23.64 21.81 22.01 22.24 21.78 21.86 21.87 21.95 21.12	41093 2640.3 23.69 23.15 23.66 21.91 22.08 22.13 22.13 22.18 22.11 21.78	2687.5 23.66 22.82 23.35 22.04 22.25 22.17 22.17 22.17 22.09 21.92
(MHz) 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	QPSK QPSK QPSK QPSK QPSK QPSK QPSK 16QAM 16QAM 16QAM	1 1 12 12 12 25 1 1 1 1	0 12 24 0 7 13 0 0 12 24	2498.5 23.17 23.63 23.66 21.90 22.08 22.00 22.06 22.33 22.01 22.02	40148 2545.8 23.64 23.52 23.57 21.74 21.77 22.04 21.76 22.07 21.91 22.04	40620 2593 23.56 23.51 23.64 21.81 22.01 22.24 21.78 21.86 21.87 21.95	41093 2640.3 23.69 23.15 23.66 21.91 22.08 22.13 22.18 22.18 22.11 21.78 21.98	2687.5 23.66 22.82 23.35 22.04 22.25 22.17 22.17 22.09 21.92 21.76
(MHz) 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	QPSK QPSK QPSK QPSK QPSK QPSK QPSK 16QAM 16QAM 16QAM 16QAM	1 1 12 12 12 25 1 1 1 1 1 12	0 12 24 0 7 13 0 0 12 24 0	2498.5 23.17 23.63 23.66 21.90 22.08 22.00 22.06 22.33 22.01 22.02 21.15	40148 2545.8 23.64 23.52 23.57 21.74 21.77 22.04 21.76 22.07 21.91 22.04 21.05	40620 2593 23.56 23.51 23.64 21.81 22.01 22.24 21.78 21.86 21.87 21.95 21.12	41093 2640.3 23.69 23.15 23.66 21.91 22.08 22.13 22.13 22.18 22.11 21.78 21.98 21.25	2687.5 23.66 22.82 23.35 22.04 22.25 22.17 22.17 22.09 21.92 21.76 21.04

#### **Radiated Measurement:** Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 41; recorded worst case for each Channel Bandwidth of LTE FDD Band 41.

2.  $EIRP=P_{Mea}(dBm)-P_{cl}(dB)+P_{Ag}(dB)+G_{a}(dBi)$ 

LTE TDD Ba	and 41_Ch	annel Bar	ndwidth 5MF	Hz_QPSK				
Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
2498.5	-16.82	4.32	6.8	36.13	21.79	33.01	-11.22	V
2593.0	-16.07	4.36	6.55	36.26	22.38	33.01	-10.63	VcTP
2687.5	-16.04	4.51	6.37	36.54	22.36	33.01	-10.65	V
		10	1 1 11 101					

LTE TDD Band 41 Channel Bandwidth 10MHz QPSK

Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization		
2501.0	-16.92	4.32	6.8	36.13	21.69	33.01	-11.32	V		
2593.0	-15.82	4.36	6.55	36.26	22.63	33.01	-10.38	SIV		
2685.0	-15.45	4.51	6.37	36.54	22.95	33.01	-10.06	V		
LTE TDD Band 41_Channel Bandwidth 15MHz_QPSK										

#### LTE TDD Band 41\_Channel Bandwidth 15MHz\_QPSK

Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
2503.5	-16.24	4.32	6.8	36.13	22.37	33.01	-10.64	V
2593.0	-16.10	4.36	6.55	36.26	22.35	33.01	-10.66	V
2682.5	-16.38	4.51	6.37	36.54	22.02	33.01	-10.99	V
LTE TDD B	and 41_Ch	annel Bai	ndwidth 20N	/Hz_QPSK		CTA .		
					Durot			

#### LTE TDD Band 41\_Channel Bandwidth 20MHz\_QPSK

- 1	Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1	2506.0	-16.35	4.32	6.8	36.13	22.26	33.01	-10.75	V
	2593.0	-16.32	4.36	6.55	36.26	22.13	33.01	-10.88	V
	2680.0	-15.94	4.51	6.37	36.54	22.46	33.01	-10.55	V

#### LTE TDD Band 41\_Channel Bandwidth 5MHz\_16QAM

Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
2498.5	-17.00	64.32	6.8	36.13	21.61	33.01	-11.40	V
2593.0	-17.40	4.36	6.55	36.26	21.05	33.01	-11.96	V
2687.5	-16.61	4.51	6.37	36.54	21.79	33.01	-11.22	V

#### LTE TDD Band 41\_Channel Bandwidth 10MHz\_16QAM

	Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	E
	2501.0	-17.18	4.32	6.8	36.13	21.43	33.01	-11.58	V	
	2593.0	-18.28	4.36	6.55	36.26	20.17	33.01	-12.84	V	
	2685.0	-16.56	4.51	6.37	36.54	21.84	33.01	-11.17	V	
P	~		-6	STING						

#### LTE TDD Band 41\_Channel Bandwidth 15MHz\_16QAM

Report No.:	CTA241210			ge 14 of 24						
LTE TDD B	and 41_Cr	nannel Bai	ndwidth 15MHz_16QAM				CTATES !!			
Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization		
2503.5	-18.23	4.32	6.8	36.13	20.38	33.01	-12.63	V		
2593.0	-18.00	4.36	6.55	36.26	20.45	33.01	-12.56	V		
2682.5	-17.15	4.51	6.37	36.54	21.25	33.01	-11.76	V		

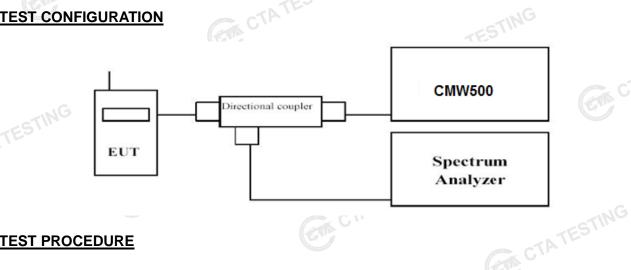
	2002.0	-17.15	4.31	0.37	30.34	Z1.Z0	33.01	-11.70	V	
	LTE TDD Ba	and 41_Ch	annel Bar	dwidth 20M	1Hz_16QAN	Λ	CTATE?	5		
	Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	G <sub>a</sub> Antenna Gain(dB)	P <sub>Ag</sub> (dB)	Burst Average EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	
	2506.0	-18.12	4.32	6.8	36.13	20.49	33.01	-12.52	V	
C	2593.0	-18.28	4.36	6.55	36.26	20.17	33.01	-12.84	V	
Ĭ	2680.0	-15.44	4.51	6.37	36.54	22.96	33.01	-10.05	V	
		en	C.		GM CT	ATESTIN		CTAT	TESTING	

#### Peak-to-Average Ratio (PAR) 3.2

#### LIMIT

The Peak-to-Average Ratio (PAR) of the transmission may not exceed 13 dB.

#### TEST CONFIGURATION



#### **TEST PROCEDURE**

- 1. Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
  - Set resolution/measurement bandwidth ≥ signal's occupied bandwidth;
  - 3. Set the number of counts to a value that stabilizes the measured CCDF curve;
  - 4. Set the measurement interval as follows:
    - 1). for continuous transmissions, set to 1 ms,

2). for burst transmissions, employ an external trigger that is synchronized with the EUT burst CTATEST timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.

---Passed-----

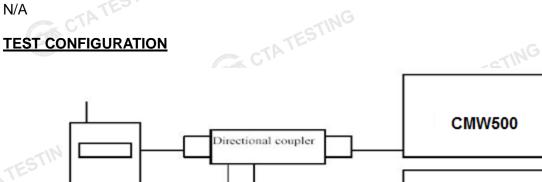
5. Record the maximum PAPR level associated with a probability of 0.1%.

#### **TEST RESULTS**

Please refer to the appendix test data.



### 3.3 Occupied Bandwidth and Emission Bandwidth LIMIT



## Spectrum Analyzer

#### **TEST PROCEDURE**

EUT

CTATESTING The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at low, middle and high channel in each band. The -26dBc Emission bandwidth was also measured and recorded.

Set RBW was set to about 1% of emission BW. VBW≥3 times RBW.

-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

---Passed-----

#### **TEST RESULTS**

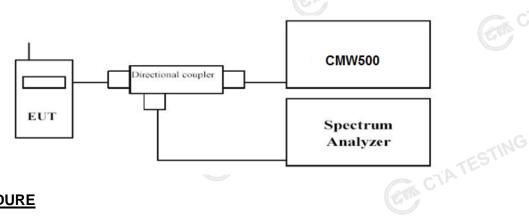
..d. Please refer to the appendix test data.

#### **Band Edge compliance** 3.4

#### LIMIT

For LTE TDD Band 41: Per §27.53 (m)(6) Measurement procedure. Compliance with these rules is based on the use of measurement instrumentation employing a resolution bandwidth of 1 megahertz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed; for mobile digital stations, in the 1 megahertz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least two percent may be employed, except when the 1 megahertz band is 2495-2496 MHz, in which case a resolution bandwidth of at least one percent may be employed. A narrower resolution bandwidth is permitted in all cases to improve measurement accuracy provided the measured power is integrated over the full required measurement bandwidth (i.e. 1 megahertz or 1 percent of emission bandwidth, as specified; or 1 megahertz or 2 percent for mobile digital stations, except in the band 2495-2496 MHz). The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emissions are attenuated at least 26 dB below the transmitter power. With respect to television operations, measurements must be made of the separate visual and aural operating powers at sufficiently frequent intervals to ensure compliance with the rules. (m)(4) For mobile digital stations, the attenuation factor shall be not less than  $40 + 10 \log (P) dB$  on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees. Show citation box.

#### **TEST CONFIGURATION**



#### **TEST PROCEDURE**

- 1. The transmitter output port was connected to base station.
- The RF output of EUT was connected to the power meter by RF cable and attenuator, the path loss was compensated to the results for each measurement.

--Passed--

- 3. Set EUT at maximum power through base station.
- 4. Select lowest and highest channels for each band and different modulation.
- CTATES 5. Measure Band edge using RMS (Average) detector by spectrum

#### TEST RESULTS

Please refer to the appendix test data.

#### 3.5 Spurious Emission

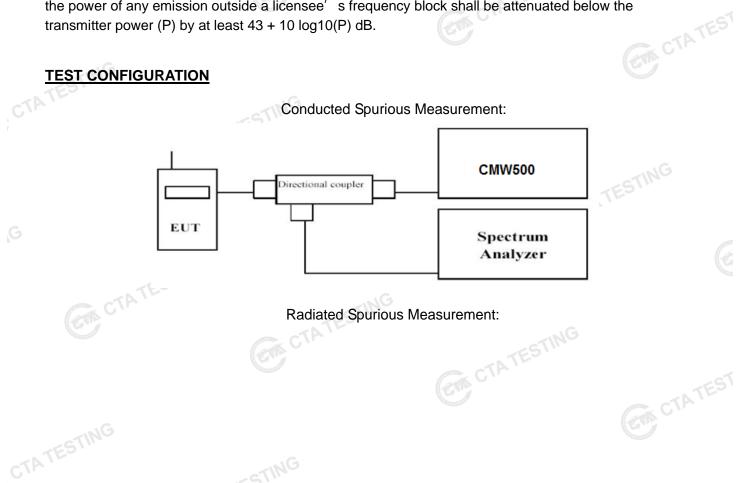
#### LIMIT

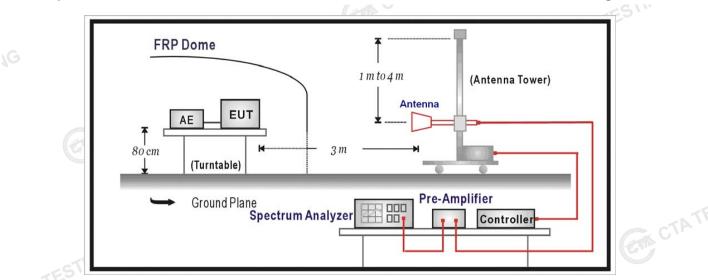
For LTE TDD Band 41: Per §27.53 (m)(6) Measurement procedure. Compliance with these rules is based on the use of measurement instrumentation employing a resolution bandwidth of 1 megahertz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed; for mobile digital stations, in the 1 megahertz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least two percent may be employed, except when the 1 megahertz band is 2495-2496 MHz, in which case a resolution bandwidth of at least one percent may be employed. A narrower resolution bandwidth is permitted in all cases to improve measurement accuracy provided the measured power is integrated over the full required measurement bandwidth (i.e. 1 megahertz or 1 percent of emission bandwidth, as specified; or 1 megahertz or 2 percent for mobile digital stations, except in the band 2495-2496 MHz). The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emissions are attenuated at least 26 dB below the transmitter power. With respect to television operations, measurements must be made of the separate visual and aural operating powers at sufficiently frequent intervals to ensure compliance with the rules. (m)(4) For mobile digital stations, the attenuation factor shall be not less than  $40 + 10 \log (P) dB$  on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition, the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHz and 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licensees operating on frequencies below 2495 MHz may also submit a documented interference complaint against BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees. Show citation box.

For LTE FDD Band 66: Per §27.53(h): For operations in the 1710–1780 MHz and 2110–2200 MHz bands,

the power of any emission outside a licensee' s frequency block shall be attenuated below the transmitter power (P) by at least 43 + 10 log10(P) dB.

## **TEST CONFIGURATION**





#### TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

#### **Conducted Spurious Measurement:**

- a. Place the EUT on a bench and set it in transmitting mode.
- b. Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
- c. EUT Communicate with CMW500 then selects a channel for testing.
- d. Add a correction factor to the display of spectrum, and then test.
- e. The resolution bandwidth of the spectrum analyzer was set sufficient scans were taken to show the out of band Emission if any up to10th harmonic.

#### **Radiated Spurious Measurement:**



- a. The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- b. The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c. The output of the test antenna shall be connected to the measuring receiver.
- d. The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e. The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
- f. The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- The test antenna shall be raised and lowered again through the specified range of height until a g. maximum signal level is detected by the measuring receiver.
- h. The maximum signal level detected by the measuring receiver shall be noted.
- The transmitter shall be replaced by a substitution antenna. ì.
- The substitution antenna shall be orientated for vertical polarization and the length of the j. substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k. The substitution antenna shall be connected to a calibrated signal generator.
- If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to Ι. increase the sensitivity of the measuring receiver.
- m. The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- n. The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- o. The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.
- p. The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- CTATEST q. The resolution bandwidth of the spectrum analyzer was set at 100 kHz for Part 22 and 1MHz for Part 24. The frequency range was checked up to 10th harmonic.
- r. Test site anechoic chamber refer to ANSI C63.

## TEST RESULTS

#### **Conducted Measurement:**

-Passed---

Please refer to the appendix test data. CTATESTIN

#### **Radiated Measurement:**

#### Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 41

Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	Diatance	G <sub>a</sub> Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
5012.0	-41.95	6.26	3.00	12.29	-35.92	-25.00	-10.92	Н
7518.0	-48.45	7.05	3.00	13.16	-42.34	-25.00	-17.34	Н
5012.0	-45.41	6.26	3.00	12.29	-39.38	-25.00	-14.38	V
7518.0	-52.77	7.05	3.00	13.16	-46.66	-25.00	-21.66	VCTA

LTE TDD Band 41\_Channel Bandwidth 20MHz\_QPSK\_ Middle Channel

Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	Diatance	G <sub>a</sub> Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization		
5186.0	-42.25	7.26	3.00	10.03	-39.48	-25.00	-14.48	Н		
7779.0	-51.14	8.48	3.00	11.41	-48.21	-25.00	-23.21	HG		
5186.0	-45.80	7.26	3.00	10.03	-43.03	-25.00	-18.03	SIV		
7779.0	-52.84	8.48	3.00	11.41	-49.91	-25.00	-24.91	V		
LTE TDD Band 41_Channel Bandwidth 20MHz_QPSK_ High Channel										

LTE TDD Band 41\_Channel Bandwidth 20MHz\_QPSK\_ High Channel

Frequency (MHz)	P <sub>Mea</sub> (dBm)	P <sub>cl</sub> (dB)	Diatance	G₂ Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	E			
5360.0	-42.90	7.17	3.00	9.62 🖸	-40.45	-25.00	-15.45	Н				
8040.0	-50.16	8.39	3.00	11.46	-47.09	-25.00	-22.09	Н				
5360.0	-40.83	7.17	3.00	9.62	-38.38	-25.00	-13.38	V				
8040.0	-49.57	8.39	3.00	11.46	-46.50	-25.00	-21.50	V				
2. EIRP=PM	Notes: 1.All channel bandwidth were tested,the report recorded the worst data. 2. EIRP=PMea(dBm)-Pcl(dB)+PAg(dB)+Ga(dBi) 3. ERP = EIRP – 2.15dBi as EIRP by subtracting the gain of the dipole.											

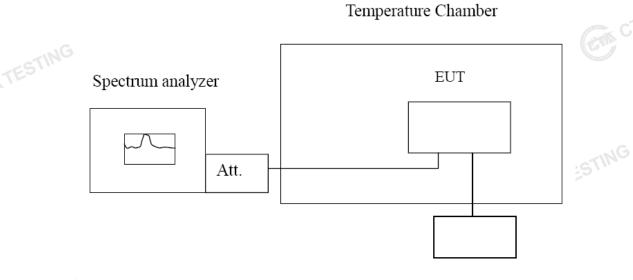
- 4. Margin = EIRP Limit
- 5. We measured all modes and only recorded the worst case. COM CTATES



#### LIMIT

According to §27.54, §2.1055 requirement, the frequency stability shall be sufficient to ensure that the fundamental emissions stay within the authorized bands of operation and should not exceed 2.5ppm. CTATESTING

#### **TEST CONFIGURATION**



Variable Power Supply

#### **TEST PROCEDURE**

The EUT was setup according to EIA/TIA 603D

#### **Frequency Stability under Temperature Variations:**

TATES In order to measure the carrier frequency under the condition of AFC lock, it is necessary to make measurements with the EUT in a "call mode". This is accomplished with the use of R&S CMW500 DIGITAL RADIO COMMUNICATION TESTER.

- Measure the carrier frequency at room temperature. 1.
- Subject the EUT to overnight soak at -30°C. 2.
- With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call 3. on middle channel for LTE band 12, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
- 4. Repeat the above measurements at 10°C increments from -30°C to +50°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements.
- 5. Re-measure carrier frequency at room temperature with nominal voltage. Vary supply voltage from minimum voltage to maximum voltage, in 0.1Volt increments re-measuring carrier frequency at each voltage. Pause at nominal voltage for 1.5 hours unpowered, to allow any selfheating to stabilize, before continuing.
- Subject the EUT to overnight soak at +50°C. 6.
- With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call 7. on the centre channel, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
- 8. Repeat the above measurements at 10 °C increments from +50 °C to -30 °C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements
- 9. At all temperature levels hold the temperature to  $+/-0.5^{\circ}$  during the measurement procedure. Frequency Stability under Voltage Variations:

Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation (±15%) and endpoint, record the maximum frequency change.

-Passed-----

# TEST RESULTS

Please refer to the appendix test data.

